## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10735680	NAKANO ET AL.
Examiner	Art Unit
Franklin, Richard	2181

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES				
Search Notes	Date	Examiner		
Updated EAST Search	4/6/07	RBF		
PLUS 2.0 Search	4/4/07	RBF		
Alan Chen (Patent Examiner; AU 2182; 710/1-74)	4/5/07	RBF		
David Martinez (Patent Examiner; AU 2181; 710/1-74)	4/5/07	RBF		
Inventor Name Search	4/3/07	RBF		
365/200; 710/1,5-7; 711/103,164,167,170 (Limited EAST Text Search)	4/6/07	RBF		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

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